

## **SUPPORT VECTOR CHARACTERIZATION OF THE MICROSTRIP ANTENNAS BASED ON MEASUREMENTS**

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**Abstract**—In this work, Support Vector Machine (SVM) formulation is worked out based upon “ $L$ ” measured data for the resonant frequency, operation bandwidth, input impedance of a rectangular microstrip antenna. Results of the formulation are compared with the theoretical results obtained in literature, much better characterization is observed with greater accuracy. At the same time, Artificial Neural Network (ANN) is employed in generalization of the data on the resonant frequency, operation bandwidth, and input impedance of the antenna. Performances of the two advanced nonlinear learning machines are compared and superiority of the SVM is verified.

### **1. INTRODUCTION**

Microstrip antennas have been used in aircraft, missile, satellite and many government and commercial applications, where size, weight, cost, performance, ease of installation and aerodynamic profile are constraints [1]. These antennas are low-profile, conformable to planar and non-planar surfaces, simple and inexpensive to manufacture using modern printed circuit technology, mechanically robust when mounted on rigid surfaces, compatible with MMIC designs, and when particular patch shape and mode selected they are very versatile in terms of resonant frequency, polarization, pattern and impedance [2].

Often microstrip antennas are also referred as patch antennas because of the radiating elements (patches) photoetched on the dielectric substrate. This radiating patch may be square, rectangular, circular, elliptical, triangular, and any other configuration. In this work, rectangular microstrip antennas are the ones under consideration

(Fig. 1). Patch dimensions of rectangular microstrip antennas are usually designed so its pattern maximum is normal to the patch. Because of their narrow bandwidths and effectively operating in the vicinity of resonant frequency, the analysis of the microstrip antennas is very important.

Two kinds of theoretical approaches can be exploited in characterizing the resonant frequency, bandwidth, input impedance of the patch antennas. The first group starts from initial physical assumptions, which generally offers simple and analytical formulas, well suited for a physical understanding of phenomena and for future antenna computer-aided design (CAD). These methods are known as transmission-line models and cavity models. However, these methods do not consider rigorously the effects of surface waves. The second approach is based on an electromagnetic boundary problem, which leads to an expression as an integral equation, using proper Green functions, either in the spectral domain, or directly in the space domain, using moment methods. Without any initial assumption, the choice of test functions and the path integration appear to be more critical during the final, numerical solution. Exact mathematical formulations in the second group rigorous methods involve extensive numerical procedures, resulting in round-off errors, and may also need final experimental adjustments to the theoretical results. They are also time consuming and not easily included in a CAD system. However, the theoretical values obtained by using both these two theoretical methods are also not in very good agreement with the experimental results of both electrically thin and thick rectangular microstrip antennas [3–5]. For these reasons, some numerical/experimental methods for the analysis of microstrip antennas is worked out [6–9]. In this work an advanced nonlinear learning machine, “Support Vector Machine (SVM)” is employed in analyzing the rectangular patch antenna, which enable to generalize ‘discrete’ data into the ‘continuous’ domain. In particular, SVMs are based on a judicious and rigorous mathematics combining the generalization and optimization theories together and verified to be computationally very efficient (the so-called Vapnik-Chervonenkis theory [10, 11]). This learning machine has found many fruitful applications in science and engineering, especially the typical applications in signal processing, modeling of microwave devices and antennas are given in [12–20].

In this work, SVMs are employed for regression in the analysis of the rectangular patch antennas, which in these types of applications, may be named as “Support Vector Regressors (SVR)”. Given a set of observed discrete data  $\{(\mathbf{x}_i, y_i) \mid \mathbf{x}_i \in \mathbf{R}^n, y_i \in \mathbf{R}, i = 1, 2, \dots, L\}$  the support vector machine learning method in its basic form creates an

approximation function  $f(\mathbf{x}) = b + \sum y_i \alpha_j K(\mathbf{x}_j, \mathbf{x})$  with  $y \cong f(\mathbf{x})$  for regression and  $y = \text{sgn } f(\mathbf{x})$  for dichotomous classification for instance. In this work, data ensemble is provided from the experiments made in the literature. Thus, the three functions characterizing the antenna are approximated in terms of the geometrical parameters which include the electrical thickness, the dimensions of the rectangular patch, the parameter of the feeding position and the electrical properties of the used dielectric material. The outputs of the SVR functions for the patch antennas designed on the widely used dielectrics are compared with the target value, artificial neural networks (ANN) which are powerful tools in modeling of transmission lines and antennas [17–22] and the theoretical counterparts in the literature [3–5].

## 2. SUPPORT VECTOR MACHINES IN REGRESSION

The regression problem related to the estimation of the resonant frequency ( $f_r$ ), bandwidth ( $BW$ ) and input impedance ( $R_{in}$ ) functions can be stated as follows: Firstly, let us consider  $f_r$ . In the training phase a set of  $L$  training pairs  $\{(\mathbf{x}^0, f_r^0), (\mathbf{x}^1, f_r^1), \dots, (\mathbf{x}^{L-1}, f_r^{L-1})\}$  is constructed by considering  $(\mathbf{x})$  as the input variable vector and  $(f_r)$  as the output. Starting from these samples of the input/output values of  $f_r$ , the goal is to find a function  $\tilde{f}_r$ , which approximates as well as possible unknown function  $f_r(\mathbf{x})$ . By using the support vector regression,  $\tilde{f}_r$  is defined as:

$$\tilde{f}_r(\mathbf{x}) = \langle \mathbf{w}, \boldsymbol{\varphi}(\mathbf{x}) \rangle + b, \quad (1)$$

where  $\langle \dots \rangle$  denotes the inner product,  $\boldsymbol{\varphi}$  is a nonlinear mapping vector that performs a transformation of the input vector to a high-dimensional space.  $\mathbf{w}$  and  $b$  are the weighting vector and bias, respectively which are obtained by minimizing the primal convex objective function (Regression Risk), defined as [11]:

$$R_{reg} = \frac{1}{2} \|\mathbf{w}\|^2 + C \sum_{i=0}^{L-1} L^\varepsilon(\mathbf{x}, f_r, \tilde{f}_r) \quad (2)$$

where  $C$  is the regularization constant and  $L^\varepsilon(\mathbf{x}, f_r)$  is a general loss function. Since the given objective function given in (2) has no local minima and it guarantees the global minimum, which is one of the superiority of support vector machines on the other pattern recognition methods, particularly neural networks. In our work, so-

called  $\varepsilon$ -insensitive loss function developed by Vapnik [10] is used:

$$L^\varepsilon(\mathbf{x}, f_r, \tilde{f}_r) = \begin{cases} 0, & \text{if } |f_r^i - \tilde{f}_r(\mathbf{x}^i)| \leq \varepsilon \\ |f_r^i - \tilde{f}_r(\mathbf{x}^i)| - \varepsilon, & \text{else} \end{cases} \quad (3)$$

this defines an  $\varepsilon$  tube so that if the predicted value is within the tube, the loss is zero, while if the predicted point is outside the tube, the loss is the magnitude of the difference between the predicted value and the radius of the tube.

According to [10] and [11], it is possible to recast the minimization of the regression risk as a dual optimization problem, in which the vector can be written in terms of the input data  $\mathbf{x}$  as:

$$\mathbf{w} = \sum_{i=0}^{L-1} (\alpha_i - \alpha'_i) \boldsymbol{\varphi}(\mathbf{x}^i) \quad (4)$$

where  $\alpha_i$  and  $\alpha'_i$  are the unknown Lagrange multipliers. By substituting (4) in (1),  $\tilde{Z}_0$  is rewritten as

$$\begin{aligned} \tilde{f}_r(\mathbf{x}) &= \sum_{i=0}^{L-1} (\alpha_i - \alpha'_i) \langle \phi(\mathbf{x}^i), \phi(\mathbf{x}) \rangle + b \\ &= \sum_{i=0}^{L-1} (\alpha_i - \alpha'_i) K(\mathbf{x}^i, \mathbf{x}) + b \end{aligned} \quad (5)$$

and the coefficients  $\alpha_i, \alpha'_i$  and must be chosen in order to minimize the regression risk in the dual problem. In (5), the kernel function  $K(\mathbf{x}^i, \mathbf{x}) = \langle \phi(\mathbf{x}^i), \phi(\mathbf{x}) \rangle$  works on the original space. Commonly used kernels are polynomial and radial kernels.

Applying the standard Lagrange multiplier technique results in the equivalent maximization of the dual space objective function [11]:

$$\begin{aligned} W(\alpha, \alpha') &= -\varepsilon \sum_{i=0}^{L-1} (\alpha'_i + \alpha_i) + \sum_{i=0}^{L-1} f_r^i (\alpha'_i - \alpha_i) \\ &\quad - \frac{1}{2} \sum_{i=0}^{L-1} (\alpha'_i - \alpha_i) (\alpha'_i + \alpha_i) K(\mathbf{x}^i, \mathbf{x}) \end{aligned} \quad (6)$$

with the constraints:

$$0 \leq \alpha'_i, \quad \alpha_i \leq C \quad (7a)$$

$$\sum_{i=0}^{L-1} (\alpha'_i - \alpha_i) = 0 \quad (7b)$$

The dual variables  $\alpha_i, \alpha'_i$  and  $b$  are computed using the Karush-Kuhn-Tucker conditions [11] to maximize (6) subject to the constraints given by (7a), (7b). From Karush-Kuhn-Tucker conditions, it follows that only for  $|\tilde{f}_r(\mathbf{x}^i) - f_r^i| \geq \varepsilon$ , the Lagrange multipliers may be nonzero, or in the other words for all samples inside the  $\varepsilon$ -tube  $\Leftrightarrow |\tilde{f}_r(\mathbf{x}^i) - f_r^i| < \varepsilon$  the  $\alpha_i, \alpha'_i$  vanish. Therefore we have a sparse expansion of  $\mathbf{w}$  in terms of  $\mathbf{x}^i$  (i.e., we do not need all  $\mathbf{x}^i$  to describe). The samples that come with nonvanishing coefficients are called Support Vectors. The idea of representing the solution by means of a small subset of training points has also enormous computational advantages. This reduced number of non-zero parameters together with the guaranteed global minimum gains superiority to support vector machines over the alternative methods. A detailed mathematical background together with the literature can be found in [11].

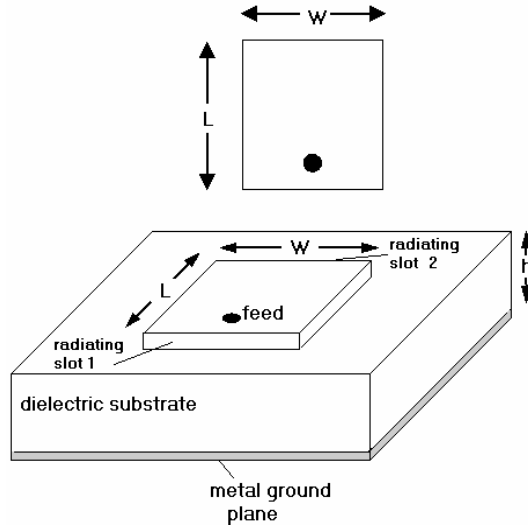
The regularization parameter  $C$  has been found to represent a measure of the tradeoff between the capabilities of the approach in estimating the resonant frequency of the patch antenna using training and test sets.

In order to correctly estimate the  $f_r, L$  data pairs in the form:  $\{(\mathbf{x}^0, f_r^0), (\mathbf{x}^1, f_r^1), \dots, (\mathbf{x}^{L-1}, f_r^{L-1})\}$  obtained from experimental results for the rectangular patch antenna are used in the training phase. At the end of the training phase, in the so-called test phase for the new dielectric substrates and geometries not included in the training set,  $f_r$  is estimated. Similarly, support vector regressors can be applied to the regression of the  $BW$  and  $R_{in}$  of the patch antenna. Numerical details of the support vector regression analysis of the patch antennas will be given in the next section.

### 3. CHARACTERIZATION OF THE RECTANGULAR MICROSTRIP ANTENNA

#### 3.1. Rectangular Microstrip Antennas

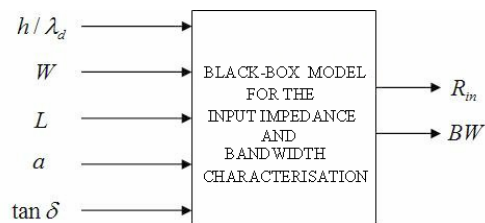
The rectangular microstrip antennas are made of a rectangular patch with dimensions, width,  $W$ , and length,  $L$ , over a ground plane with a substrate thickness,  $h$  and dielectric constant,  $\varepsilon_r$ , as given in Fig. 1. Dielectric constants are usually used in the range of  $2.2 \leq \varepsilon_r \leq 12$ . However, the most desirable ones are the dielectric constants in the lower end of this range together with the thick substrates, because they provide better efficiency, larger bandwidth, but at the expense of larger element size [27].



**Figure 1.** Rectangular microstrip antenna.

### 3.2. Black-Box Models for the Resonant Frequency, Bandwidth and Input Impedance

The black-box model is given in Fig. 2 for the training process of SVR and/or ANN characterization of bandwidth and input impedance. 27 data pairs of the experimental results in the literature [28–31] are exploited in the training process, while 6 data pairs are used for the testing as shown in Tables 1–2. Thus, SVR is employed in order to characterize the input impedance and bandwidth of the rectangular patch antenna as the functions of the antenna parameters of  $h/\lambda_d$ ,  $W$ ,  $L$ ,  $a$ ,  $\tan \delta$  with these measurement results. Here,  $h$  is the thickness of the dielectric substrate,  $\lambda_d$  is the wavelength within the substrate,  $W$  is the width of the patch,  $L$  is the length of the patch,



**Figure 2.** Black-box model for the input impedance and bandwidth characterization.

**Table 1.** The accuracies of the  $R_{in}$ ,  $BW$  and  $f_r$  functions in testing process.

| <i>% accuracy</i> | <b>SVR</b> | <b>ANN</b> |
|-------------------|------------|------------|
| $R_{in}$          | 99.8       | 98.87      |
| $BW$              | 97.85      | 98.81      |
| $f_r$             | 98.79      | 98.33      |

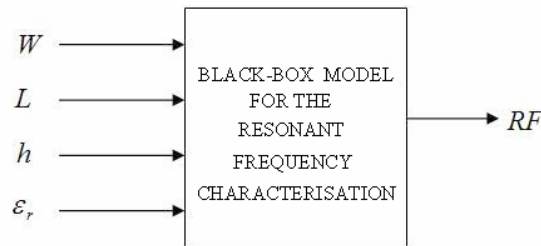
**Table 2.** Time analysis of ANN and SVR models for  $f_r$  function of the patch antenna.

|                           | <b>SVR</b> | <b>ANN*</b> |
|---------------------------|------------|-------------|
| <b>Training time(sec)</b> | 0.047      | 4.06        |
| <b>Test time (sec)</b>    | 0.012      | 0.045       |
| <b>Total time (sec)</b>   | 0.059      | 4.105       |

(\*trained for 300 epochs)

$a$  is the position of the feeding point and  $\tan \delta$  is the loss tangent.

Similarly, 37 and 9 experimental data pairs [32–35] are used in the training and testing for the resonant frequency, respectively and its black-box model is given in Fig. 3. In this model, the resonant frequency of the rectangular patch antenna is obtained as the function of input variables of  $\mathbf{W}$ ,  $\mathbf{L}$ ,  $\mathbf{h}$ ,  $\varepsilon_r$ . Here,  $\varepsilon_r$  is the dielectric constant of the substrate. The input data of both models are normalized in the range of 0 and 1.



**Figure 3.** Black-box model for the resonant frequency characterization.

### 3.3. Generating of Support Vector Regression/Artificial Neural Network for the Characterization of Microstrip Antennas

In SVR, radial basis function kernel is chosen as the most suitable kernel function in our application:

$$K(\mathbf{x}', \mathbf{x}) = \exp\left(-\gamma \|\mathbf{x} - \mathbf{x}^i\|^2\right) \quad (8)$$

where the width parameter  $\gamma$  is set to 0.1 for the optimum performance. Similarly, the regularization parameter,  $C$  is set to 1. 24 support vectors corresponding to the diameter ( $\Leftrightarrow \varepsilon = 0.1$ ) of the insensitive tube are found to be sufficient out of the 27 data pairs in the training of SVR model for the determination of  $R_{in}$  function. Similarly, 22 support vectors out of 27 data and 31 support vectors out of 37 data are used in the training of SVR models for the determination of  $BW$  and  $f_r$  functions, respectively.

The performance of the SVR is compared with ANN, which is the most competitive technique to SVR. Thus, two multilayer perception (MLP) models are used for the modeling inside the two black-boxes given in Figs. 2 and 3. ANN model for  $R_{in}$  and  $BW$  characterization has 5 and 4 neurons in its two hidden layers, and 2 output neurons. ANN model to characterize  $f_r$  has 4 and 3 neurons in its two hidden layers and a single output neuron. Hyperbolic tangent sigmoid and linear transfer functions were used in the hidden and output neurons, respectively for the MLP training.

### 3.4. Results of the SVR and/or ANN Characterization

The accuracies of the SVR and ANN models for the resonant frequency, bandwidth and input impedance are given in Table 1. One of the most important superiority of SVR to the ANN is much faster convergence rate with the sparse solution technique as seen from Table 2 where the computation efficiency of the SVR and ANN for regression of the  $f_r$  function is compared.

The test results of the SVR regression for the  $R_{in}$ ,  $BW$  and  $f_r$  of the rectangular patch antenna take place in Tables 3–5 comparatively with measured (target) values, ANN results and other theoretical values in the literature.

It can be seen from the Tables 3–5, the theoretical analyses cannot characterize the antenna accurately due to incapability of taking into account every aspects of the system, however the regression models gives the closest results to the measured ones.



**Table 3.** Comparison of the SVR results for the input impedance with the target values, ANN results and theoretical results.

| $h/\lambda_d$ | $W$   | $L$   | $a$  | $\tan \delta$ | $Rin_{me}$ | $Rin_{SVR}$ | $Rin_{ANN}$ | $Rin_{[20]}$ | $Rin_{[31]}$ | $Rin_{[32]}$ |
|---------------|-------|-------|------|---------------|------------|-------------|-------------|--------------|--------------|--------------|
| 0.0384        | 18.1  | 19.6  | 6.27 | 0.001         | 58         | 58.09       | 57.24       | 36.2         | 83.7         | 63.2         |
| 0.066         | 13.37 | 14.12 | 4.75 | 0.002         | 52         | 51.89       | 51.48       | 36.9         | 67.9         | 57.4         |
| 0.1292        | 13.75 | 15.8  | 5.82 | 0.002         | 44         | 43.90       | 43.31       | 51.5         | 47.4         | 49           |
| 0.1475        | 10    | 15.2  | 3.45 | 0.002         | 45         | 45.10       | 44.49       | 46.4         | 310.1        | 228.3        |
| 0.1814        | 12.56 | 27.56 | 3.2  | 0.002         | 46         | 46.09       | 46.56       | 45           | 1041.6       | 508          |
| 0.2182        | 10.3  | 33.8  | 3.6  | 0.002         | 47         | 47.09       | 46.76       | 46.5         | 2488.8       | 785.9        |

**Table 4.** Comparison of the SVR results for the bandwidth with the target values, ANN results and theoretical results.

| $h/\lambda_d$ | $W$   | $L$   | $a$  | $\tan \delta$ | $BW_{me}$ | $BW_{SVR}$ | $BW_{ANN}$ | $BW_{[28]}$ | $BW_{[37]}$ | $BW_{[38]}$ |
|---------------|-------|-------|------|---------------|-----------|------------|------------|-------------|-------------|-------------|
| 0.0384        | 18.1  | 19.6  | 6.27 | 0.001         | 4.9       | 4.99       | 4.73       | 6.17        | 3.96        | 2.2         |
| 0.066         | 13.37 | 14.12 | 4.75 | 0.002         | 7.7       | 7.79       | 7.66       | 9.16        | 7.29        | 4.2         |
| 0.1292        | 13.75 | 15.8  | 5.82 | 0.002         | 15.9      | 14.93      | 15.83      | 15.11       | 18.06       | 10.5        |
| 0.1475        | 10    | 15.2  | 3.45 | 0.002         | 18        | 17.68      | 17.83      | 17.47       | 14.08       | 11.8        |
| 0.1814        | 12.56 | 27.56 | 3.2  | 0.002         | 20        | 19.89      | 19.85      | 19.66       | 10.10       | 14.54       |
| 0.2182        | 10.3  | 33.8  | 3.6  | 0.002         | 21.6      | 21.91      | 21.16      | 21.73       | 7.11        | 16.95       |

**Table 5.** Comparison of the SVR results for the resonant frequency with the target values, ANN results and theoretical results.

| $W$   | $L$   | $h$    | $\epsilon_r$ | $f_{r_{me}}$ | $f_{r_{SVR}}$ | $f_{r_{ANN}}$ | $f_{r_{[2]}}$ | $f_{r_{[32]}}$ | $f_{r_{[39]}}$ | $f_{r_{[40]}}$ | $f_{r_{[41]}}$ |
|-------|-------|--------|--------------|--------------|---------------|---------------|---------------|----------------|----------------|----------------|----------------|
| 1.81  | 1.96  | 0.157  | 2.33         | 4805         | 4829          | 4782          | 4824          | 4749           | 5014           | 4635           | 4520           |
| 1.337 | 1.412 | 0.2    | 2.55         | 6200         | 6209          | 6218          | 6201          | 6053           | 6653           | 5845           | 5682           |
| 1.375 | 1.580 | 0.476  | 2.55         | 5100         | 5143          | 4923          | 5092          | 4993           | 5945           | 4667           | 4407           |
| 1     | 1.52  | 0.476  | 2.55         | 5820         | 5840          | 5889          | 5352          | 5423           | 6180           | 4855           | 4576           |
| 1.256 | 2.756 | 0.952  | 2.55         | 3580         | 3618          | 3765          | 2983          | 3115           | 3408           | 2668           | 2485           |
| 1.03  | 3.38  | 1.281  | 2.55         | 3200         | 3178          | 3169          | 2474          | 2623           | 2779           | 2183           | 1992           |
| 1.7   | 1.1   | 0.3175 | 2.33         | 6800         | 6628          | 6876          | 7405          | 6806           | 8933           | 6958           | 6467           |
| 6.858 | 4.14  | 0.152  | 2.5          | 2200         | 2266          | 2301          | 2241          | 2204           | 2292           | 2208           | 2158           |
| 0.79  | 1.185 | 0.017  | 2.22         | 8450         | 8286          | 8538          | 8478          | 8431           | 8496           | 8369           | 8298           |

#### 4. CONCLUSION

In this work, a new methodology for characterization of microstrip antennas is presented. To aim this, Support Vector Regression is adopted to the  $L$ -measured data of the rectangular patch antenna and its performance is compared with the closest counterpart, Artificial Neural Network. Support Vector Regression is found to be superior to the Artificial Neural Network with respects of generalization ability, convergence rate and computational efficiency. Moreover, both regression results are compared to the those of the pioneer theoretical analyses and it can be concluded that the theory is still insufficient for complete characterization to take into account all the effects of the system. Thus, in these cases, rigorous methodologies to regress are needed. This work also verifies that Support Vector Regression is one of the most advisable methodologies to be employed.

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